MA3SD29F

Silicon epitaxial planar type

For super high speed switching circuits

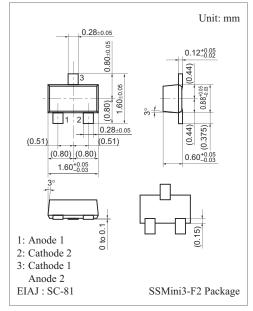
Features

- Low forward voltage V_F : < 0.42 V (at I_F = 100 mA)
- Optimum for high-frequency rectification
- Short reverse recovery time t_{rr}

Absolute Maximum Ratings $T_a = 25^{\circ}C$

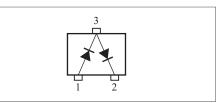
Parameter		Symbol	Rating	Unit	
Reverse voltage		V _R	30	V	
Repetitive peak reverse voltage		V _{RRM} 30		V	
Forward current (Average)	Single	I _{F(AV)}	100	mA	
	Series		75		
Peak forward current	Single	I _{FM}	200	mA	
	Series		150		
Non-repetitive peak forward surge current *		I _{FSM}	1	А	
Junction temperature		Tj	125	°C	
Storage temperature		T _{stg}	-55 to +125	°C	

Note) *: 50 Hz sine wave 1 cycle (Non-repetitive peak current)



Marking Symbol: M5R

Internal Connection



Electrical Characteristics $T_a = 25^{\circ}C \pm 3^{\circ}C$

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Forward voltage	V _{F1}	$I_F = 10 \text{ mA}$		0.25	0.29	v
	V _{F2}	$I_{\rm F} = 100 {\rm mA}$		0.39	0.42	
Reverse current	I _{R1}	$V_{R}=10 V$			25	μΑ
	I _{R2}	$V_{R}=30 V$			120	
Terminal capacitance	Ct	$V_{Rl} = 0 V, f = 1 MHz$		11		pF
Reverse recovery time *	t _{rr}	$I_F = I_{Rl} = 100 \text{ mA}, I_m = 10 \text{ mA},$ $R_{L^2} = 100 \Omega$		1		ns

Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7031 measuring methods for diodes.

2. Absolute frequency of input and output is 250 MHz

3. This product is sensitive to electric shock (static electricity, etc.). Due attention must be paid on the charge of a human body and the leakage of current from the operating equipment.

4. *: trr measurement circuit

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